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_	Application/Control No.	Applicant(s)/Patent under Reexamination	-
	10/029,310	CELIK ET AL.	
	Examiner	Art Unit	
	Dustin Nguyen	2154	

SEARCHED			
Class	Subclass	Date	Examiner
715	513, 748	2/14/2007	DN
713	1	2/14/2007	DN
717	103	2/14/2007	DN
345	762	2/14/2007	DN
379	201.04	2/14/2007	DN
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Class	Subclass	Date	Examiner
715	513, 716	2/14/2007	DN
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709	231	2/14/2007	DN
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